

**GigaDevice Semiconductor Inc.**

**Migration from GD32L233 series to  
GD32L235 series**

**Application Note**

**AN184**

Revision 1.1

(Jul.2024)

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## 1. Introduction

The GD32L235xx device is a new 32-bit general-purpose microcontroller base on the ARM® Cortex®-M23 core. It has very high similarity in resources with the GD32L233xx device. This application note aims to help customers quickly port applications from the GD32L233xx series microcontroller to the GD32L235xx series microcontroller.

In order to better use of the information in this application note, customers need to download it from the website [www.GD32MCU.com](http://www.GD32MCU.com), such as datasheet, user manual, official code and various development tools.

## 2. Introduction to hardware differences

The package types of the GD32L235xx series include: WLCSP25, QFN32, LQFP32, QFN48, LQFP48, QFN64, LQFP64; The package types of the GD32L233xx series include QFN32, LQFP32, LQFP48, and LQFP64. The pins of the two series of chips with the same package are compatible. There are slight differences in pin definitions between the two series, please refer to the datasheet documentation for details.

### 3. Comparison of resource and peripheral

There are the following differences in resources between the GD32L235xx series and the GD32L233xx series:

1. The GD32L235xx series has added the number of advanced timers and general timers; The low-power timer of the GD32L235xx series has 16 bits, and the low-power timer of the GD32L233xx series has 32 bits.
2. The GD32L235xx series has added CAN peripheral.
3. The GD32L235xx series has increased the number of LPUART peripherals.

Details can be found in [Table 3-1. Overview of Resource Comparison between GD32L235xx Series and GD32L233xx Series](#), as well as [Table 3-2. Overview of GD32L235xx series and GD32L233xx series peripheral address comparison](#).

**Table 3-1. Overview of Resource Comparison between GD32L235xx Series and GD32L233xx Series**

Peripheral	GD32L235xx	GD32L233xx
Core	Cortex-M23	Cortex-M23
Flash	64K-128K	64K-256K
RAM	12K-24K	16K-32K
主频	64MHz	64MHz
LPTM	2(16bit)	1(32bit)
GPTM(16bit)	5/6	3/4
AdvTM(16bit)	1	0
BaseTM(16bit)	2	2
U(S)ART	3/4	3/4
I2C	3	2/3
SPI	2	2
I2S	1	1
USB	0/1	1
CAN	0/1	0
CMP	2	2
ADC	1(10)/1(16)	1(10)/1(16)
DAC	1	1
SLCD	0/1	0/1
Operating Voltage	1.62-3.63V	1.71-3.63V
Temperature Range	-40-85℃	-40-85℃

**Table 3-2. Overview of GD32L235xx series and GD32L233xx series peripheral address comparison**

Peripheral	BUS	GD32L235xx	GD32L233xx
GPIOF	AHB2	0X48001400	0X48001400

## Migration from GD32L233 series to GD32L235 series

GPIOD		0X48000C00	0X48000C00
GPIOC		0X48000800	0x48000800
GPIOB		0X48000400	0X48000400
GPIOA		0X48000000	0X48000000
TRNG		0X50060800	0X50060800
CAU		0X50060000	0X50060000
CRC		0X40023000	0X40023000
FMC	AHB1	0X40022000	0X40022000
RCU		0X40021000	0X40021000
DMAMUX		0X40020800	0X40020800
DMA		0X40020000	0X40020000
TIMER40		0X4001D000	-
CMP		0X40017C00	0X40017C00
DBG		0X40015800	0X40015800
TIMER8		0X40014C00	0X40014C00
TIMER14		0X40014000	-
USART0	APB2	0X40013800	0X40013800
SPI0		0X40013000	0X40013000
TIMER0		0X40012C00	-
ADC		0X40012400	0X40012400
EXTI		0X40010400	0X40010400
SYSCFG+VREF		0X40010000	0X40010000
CTC		0X4000C800	0X4000C800
I2C2		0X4000C000	0X4000C000
LPTIMER0		0X40009400	0X40009400
LPUART0		0X40008000	0X40008000(LPUART)
LPTIMER1		0X40007C00	-
DAC0		0X40007400	0X40007400
PMU		0X40007000	0X40007000
CAN		0X40006400	-
Shared USB/D/CAN RAM(512 bytes)		0X40006000	0X40006000(USB/D RAM(512 bytes))
USB/D	APB1	0X40005C00	0X40005C00
I2C1		0X40005800	0X40005800
I2C0		0X40005400	0X40005400
UART4		0X40005000	0X40005000
UART3		0X40004C00	0X40004C00
LPUART1		0X40004800	-
USART1		0X40004400	0X40004400
SPI1/I2S1		0X40003800	0X40003800
FWDGT		0X40003000	0X40003000
WWDGT		0X40002C00	0X40002C00



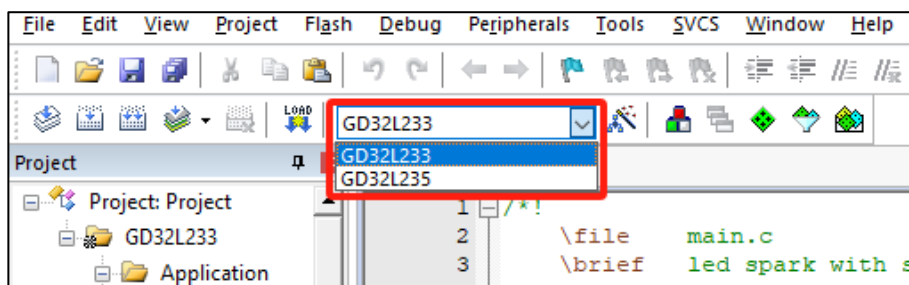
## Migration from GD32L233 series to GD32L235 series

RTC		0X40002800	0X40002800
SLCD		0X40002400	0X40002400
TIMER11		0X40001800	0X40001800
TIMER6		0X40001400	0X40001400
TIMER5		0X40001000	0X40001000
TIMER2		0X40000400	0X40000400
TIMER1		0X40000000	0X40000000
SRAM		0x20000000	0x20000000
Option Byte		0x1FFFF800	0x1FFFF800
Main Flash		0x08000000	0x08000000
System Memory		0x1FFFD000	0x1FFFD000
OTP		0x1FFF7000	0x1FFF7000

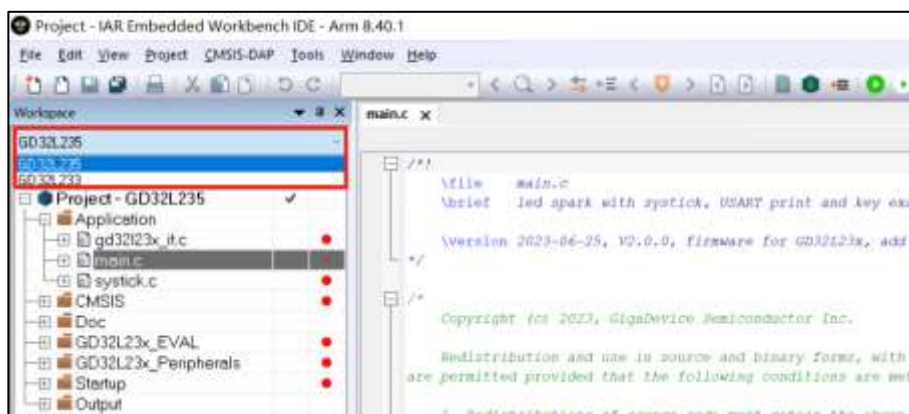
## 4. Program Migration

The GD32L233xx series and GD32L235xx series both belong to the GD32L23x series, and the new version of the firmware library GD32L23x\_ Firmware\_Library (version 2.0.0 and above) is already compatible with two series of products, GD32L233xx and GD32L235xx. When using the new version of the firmware library, simply select the corresponding series, as shown in [Figure 4-1. The interface for selecting GD32L233xx series and GD32L235xx series for KEIL Project](#) and [Figure 4-2. The interface for selecting GD32L233xx series and GD32L235xx series for IAR Project](#) is shown.

**Figure 4-1. The interface for selecting GD32L233xx series and GD32L235xx series for KEIL Project**



**Figure 4-2. The interface for selecting GD32L233xx series and GD32L235xx series for IAR Project**



If GD32L235xx is running an older version of the firmware library, please refer to Chapter 5 for any issues that need to be noted.

## 5. Peripheral differences

GD32L235xx is compatible with GD32L233xx in some peripherals, but as a more advanced MCU, GD32L235xx has added some features on many peripherals compared to GD32L233xx. Users can port their code based on the differences in peripherals listed below.

### 5.1. Flash memory controller (FMC)

When using FMC code, it is important to pay attention to the following points:

1. For GD32L233xx, the flash page size is 4/2/1KB, depending on different flash density. For GD32L235xx, the flash page size is 1KB.
2. For GD32L233xx, word programming, page erase and mass erase operation supported. For GD32L235xx, double-word programming, page erase and mass erase operations supported.
3. Fast program supported (only available in GD32L233).
4. ECC check supported (only available in GD32L235)
5. For GD32L233xx product, flash can work at LDO 1.1V and 0.9V; For GD32L235xx, flash only works at LDO 1.1V.
6. GD32L235xx product has SRAM parity check function, which GD32L233xx product does not have. In the option byte USER section of GD32L235xx product, there is a disable enable bit with SRAM parity check. The parity check function of GD32L235xx SRAM is enabled by default, as shown in [Figure 5-1. Set the SRAM PARITY CHECK bit to disable or enable SRAM parity check](#). Before MCU system initialization, SRAM needs to be initialized to 0. If initialization is not performed, parity check will report an error and enter NMI interrupt. See [Figure 5-2 Initialize SRAM before MCU system initialization](#). When users do not need to use this function, they can operate on the option byte to turn off this function.

**Figure 5-1. Set the SRAM\_PARITY\_CHECK bit to disable or enable SRAM parity**

check

0x1fff802	USER	<p>[7:5]: BOR_TH (Brown out reset threshold)</p> <p>000/101/110/111: BOR Level 0, brownout threshold level 0 (1.6V)</p> <p>001: BOR Level 1, brownout threshold level 1 (2.0V)</p> <p>010: BOR Level 2, brownout threshold level 2 (2.2V)</p> <p>011: BOR Level 3, brownout threshold level 3 (2.5V)</p> <p>100: BOR Level 4, brownout threshold level 4 (2.8V)</p> <p>[4]: reserved</p> <p>[3]: SRAM_PARITY_CHECK</p> <p>0: disable SRAM parity check</p> <p>1: enable SRAM parity check</p> <p>[2]: nRST_STDBY</p> <p>0: generate a reset instead of entering standby mode</p> <p>1: no reset when entering standby mode</p> <p>[1]: nRST_DPSLP</p> <p>0: generate a reset instead of entering deep-sleep mode</p> <p>1: no reset when entering deep-sleep mode</p> <p>[0]: nWDG_HW</p> <p>0: hardware free watchdog</p> <p>1: software free watchdog</p>
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Figure 5-2. Initialize SRAM before MCU system initialization

```

/* reset Handler */
Reset_Handler PROC
EXPORT Reset_Handler [WEAK]

LDR r0, =0x1FFFF7E0
LDR r2, [r0]
LDR r0, =0xFFFF0000
ANDS r2, r2, r0
LSRS r2, r2, #16
LSLS r2, r2, #10
LDR r1, =0x20000000
MOVS r0, #0x00
SRAM_INIT STM r1!, {r0}
SUBS r2, r2, #4
CMP r2, #0x00
BNE SRAM_INIT

IMPORT SystemInit
IMPORT __main
LDR R0, =SystemInit
BLX R0
LDR R0, =__main
BX R0
ENDP
    
```

## 5.2. Power management uint(PMU)

For GD32L233xx devices:

1. Internal Voltage regulator (LDO) supplies around 1.1V or 0.9V voltage source for 1.1V domain.

## Migration from GD32L233 series to GD32L235 series

2. Ten power saving modes: Run, Run1, Run2, Sleep, Sleep1, Sleep2, Deep-sleep, Deep-sleep 1, Deep-sleep 2 and Standby modes.
3. CAU can be power off alone.

For GD32L235xx devices:

1. Internal Voltage regulator (LDO) supplies around 1.1V source for 1.1V domain.
2. Six power saving modes: Run, Sleep, Deep-sleep, Deep-sleep 1, Deep-sleep 2 and Standby modes.
3. Internal Voltage regulator (LDO) supplies around 0.9V voltage source for 1.1V domain when in Deep-sleep 1 or Deep-sleep 2 mode.
4. EFLASH can be power-off alone when in run or Deep-sleep mode.

### 5.3. Reset and clock unit (RCU)

1. For GD32L233xx devices, the LPUART is clocked by IRC16MDIV clock or LXTAL clock or system clock or APB1 clock, which selected by LPUARTSEL bits in configuration register 2 (RCU\_CFG2). For GD32L235xx devices, the LPUART<sub>x</sub>( $x = 0, 1$ ) is clocked by IRC16MDIV clock or LXTAL clock or system clock or APB1 clock, which selected by LPUART<sub>x</sub>SEL( $x = 0, 1$ ) bits in configuration register 2 (RCU\_CFG2).
2. For GD32L233xx devices, the LPTIMER is clocked by IRC16MDIV clock or LXTAL clock or system clock or APB1 clock, which selected by LPTIMERSEL bits in configuration register 2(RCU\_CFG2). For GD32L235xx devices, the LPTIMER<sub>x</sub>( $x = 0, 1$ ) is clocked by IRC16MDIV clock or LXTAL clock or system clock or APB1 clock, which selected by LPTIMER<sub>x</sub>SEL( $x = 0, 1$ ) bits in configuration register 2 (RCU\_CFG2).
3. The GD32L23x's system clock (CK\_SYS) which can source from the IRC16M, IRC48M, HXTAL, IRC32K (Only for GD32L235 devices) or PLL. The system clock source of GD32L233xx product does not include IRC32K.

### 5.4. Interrupt / event controller (EXTI)

1. Up to 69 maskable peripheral interrupts (for GD32L233xx devices) or 72 maskable peripheral interrupts (for GD32L235xx devices).
2. Up to 30 independent edge detectors (for GD32L233xx devices) or 32 independent edge detectors (for GD32L235xx devices) in EXTI.

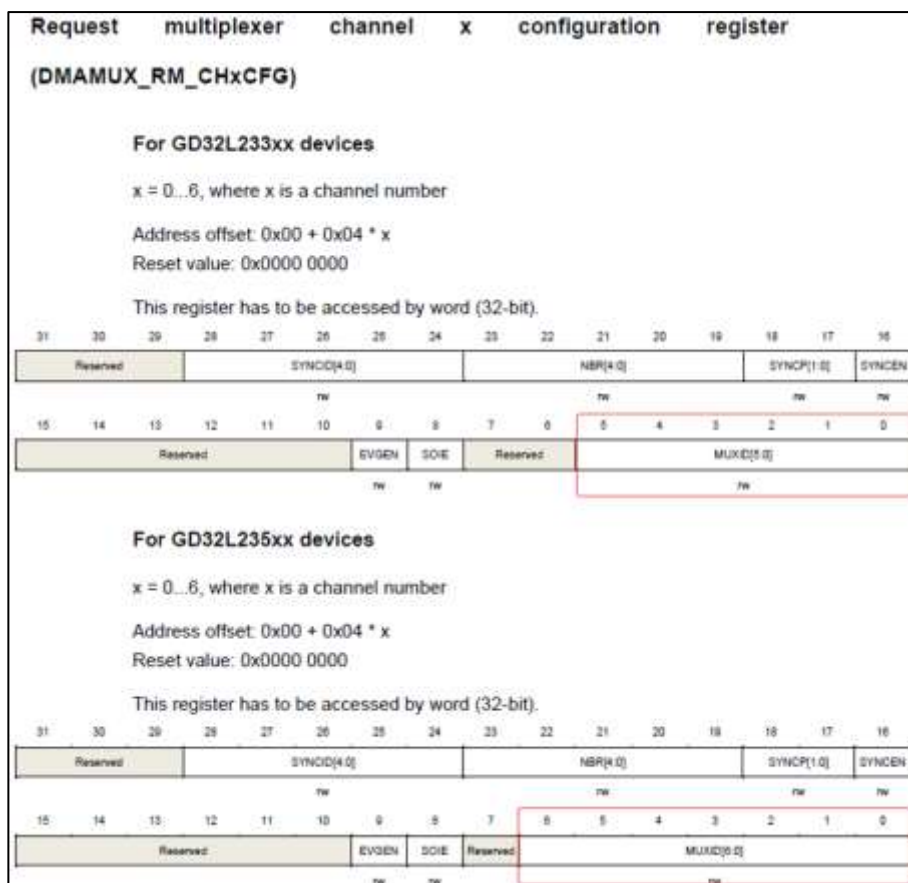
### 5.5. DMA request multiplexer (DMAMUX)

A DMA request input for the DMAMUX request multiplexer channel  $x$  is configured by the

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MUXID[5:0] (for GD32L233xx devices)/ MUXID[6:0](for GD32L235xx devices) bits in the DMAMUX\_RM\_CHxCFG register. See [Figure 5-3. The comparison of DMAMUX\\_RM\\_CHxCFG register between GD32L233xx series and GD32L235xx series](#), specific usage can be found in the Request multiplexer input mapping in the GD32L23x user manual.

**Figure 5-3. The comparison of DMAMUX\_RM\_CHxCFG register between GD32L233xx series and GD32L235xx series**



### 5.6. Debug (DBG)

The DBG hold unit helps debugger to debug power saving mode, TIMER, LPTIMER, I2C, CAN, RTC, WWDGT, and FWDGT. When the core is halted and the corresponding bit in DBG control register 0 or DBG control register 1 (DBG\_CTL0 or DBG\_CTL1) is set, it provides a clock in power saving mode or holds the state for TIMER, LPTIMER, I2C, CAN, RTC, WWDGT and FWDGT. Due to differences in peripherals between L233xx and L235xx series, the difference of DGB\_CTL0 and DBG\_CTL1 register is shown in [Figure 5-4. The comparison of DGB\\_CTL0 register between GD32L233xx series and GD32L235xx series](#) and [Figure 5-5. The comparison of DGB\\_CTL1 register between GD32L233xx series and GD32L235xx series](#). Attention should be paid when using this feature.

## Migration from GD32L233 series to GD32L235 series

Figure 5-4. The comparison of DGB\_CTL0 register between GD32L233xx series and GD32L235xx series

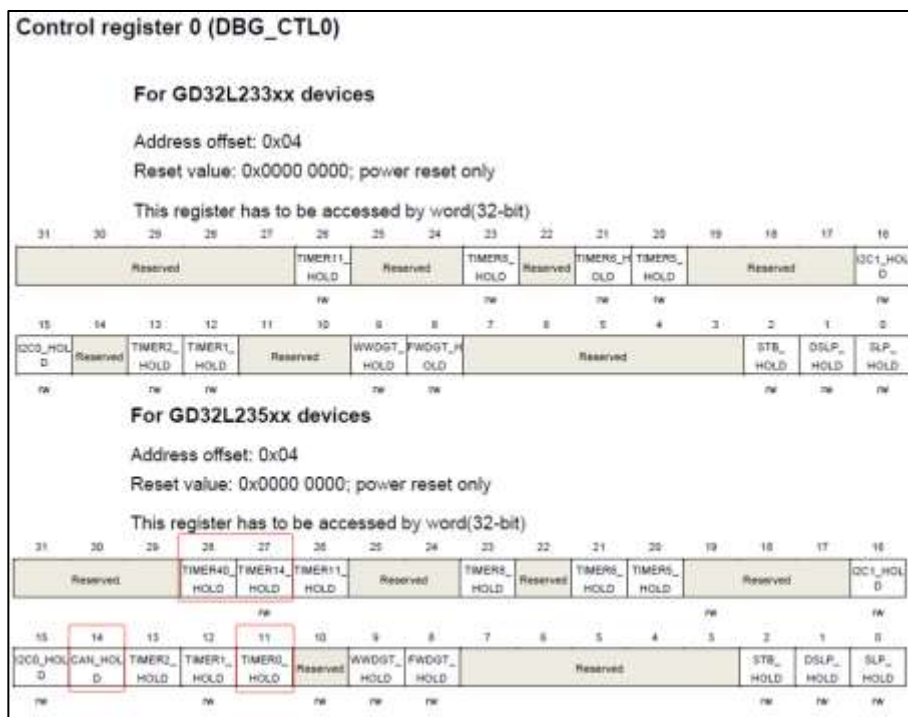
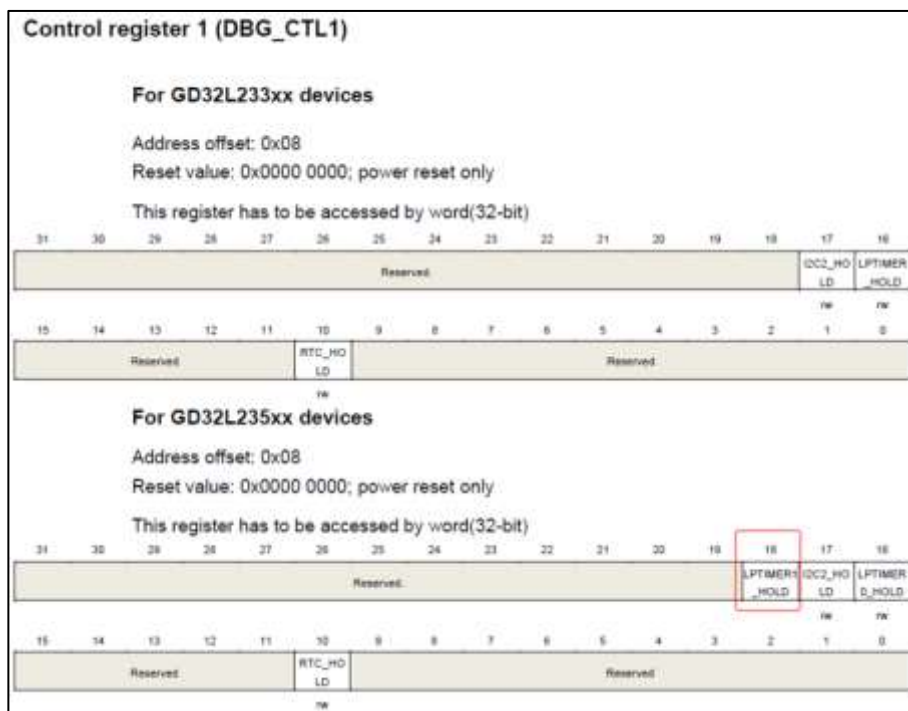


Figure 5-5. The comparison of DGB\_CTL1 register between GD32L233xx series and GD32L235xx series

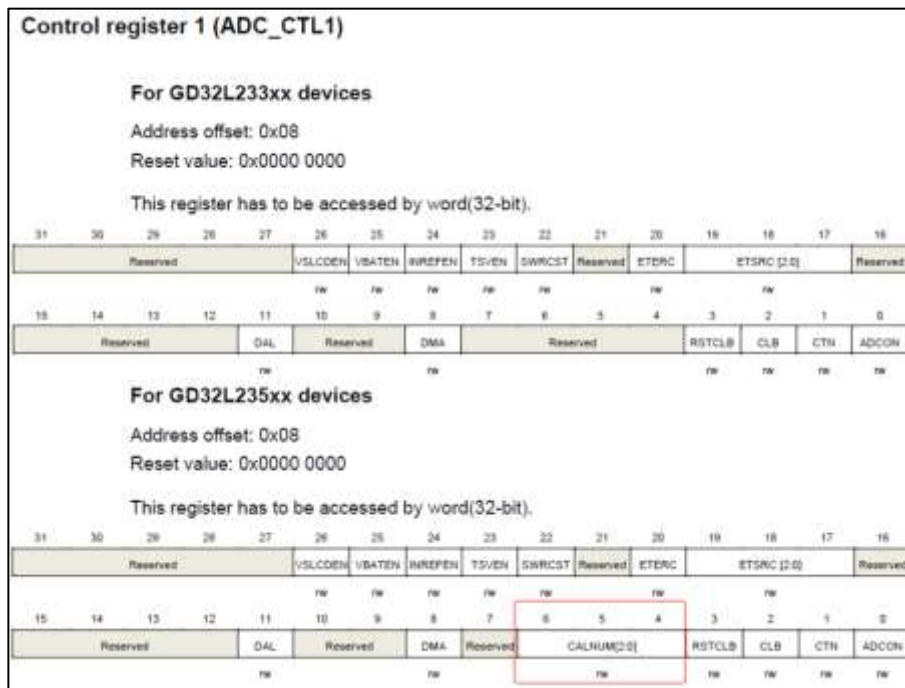




## 5.7. Analog to digital converter (ADC)

1. In GD32L23xx series, only available for GD32L235xx devices. By writing into bits DIFCTL[14:0] in the ADC\_DIFCTL register, the user can configure channels as differential input or single-ended input. The GD32L233xx devices only support single-ended input mode.
2. The GD32L235xx devices support the configuration of calibration times, while the GD32L233xx devices do not support this function, as shown in [Figure 5-6. The comparison of ADC\\_CTL1 register between GD32L233xx series and GD32L235xx series.](#)

Figure 5-6. The comparison of ADC\_CTL1 register between GD32L233xx series and GD32L235xx series



## 5.8. Timer (TIMERx)

For GD32L235xx devices: Advanced TIMER0、General level0 TIMER1/2、General level1 TIMER8/11、General level3 TIMER14/40、Basic TIMER5/6.

For GD32L233xx devices: General level0 TIMER1/2、General level1 TIMER8/11、Basic TIMER5/6.

The two series have the same configuration for handling basic timers 5/6, but have the following differences.

1. Clock source configuration for GD32L23x:



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- For GD32L235xx devices: The TIMER has the capability of being clocked by either the CK\_TIMER or an alternate clock source controlled by SMC (TIMERx\_SMCFG bit[2:0]).
  - For GD32L233xx devices: The TIMER has the capability of being clocked by either the CK\_TIMER or an alternate clock source controlled by TSCFGy[3:0] in SYSCFG\_TIMERxCFG (y=0,1...7) (x=0,1,2,8,11,14,40).
2. Mode selection of Quadrature decoder
    - For GD32L233, the mode is selected by setting the SMC[2:0] to 0x01, 0x02 or 0x03.
    - For GD32L235, the mode is selected by setting TSCFGy[3:0] != 4'b0000 (y=0,1,2).
  3. Master-slave management

The TIMERx can be synchronized with a trigger in several modes including the restart mode, the pause mode and the event mode.

- For GD32L233, these modes are selected by the SMC [2:0] in the TIMERx\_SMCFG register. The trigger input of these modes can be selected by the TRGS [2:0] in the TIMERx\_SMCFG register.
  - For GD32L235, these modes are selected by the TSCFGy[3:0] != 4'b0000 in SYSCFG\_TIMER1CFG or SYSCFG\_TIMER2CFG (y=3,4,5), The trigger input of these modes can be selected by the TSCFGy[3:0] in SYSCFG\_TIMER1CFG or SYSCFG\_TIMER2CFG, different TSCFGy[3:0] is correspond to different trigger input.
4. Timers interconnection

The timers can be internally connected together for timer chaining or synchronization. This can be implemented by configuring one timer to operate in the master mode while configuring another timer to be in the slave mode.

TIMER2 as prescaler for TIMER1, Select the TIMER1 input trigger source from TIMER2 and configure TIMER1 in external clock mode 1.

- For GD32L233, setting TRGS=000 in the TIMER1\_SMCFG register and setting SMC=111 in TIMER1\_SMCFG register.
- For GD32L235, setting TSCFG6[3:0] = 0001 in the \_SYSCFG\_TIMERxCFG register.

Note: As can be seen from the above, the GD32L235xx series requires the SYSCFG clock to be turned on before configuring TIMER.

### 5.9. Low power timer (LPTIMER)

The GD32L233xx has one 32-bit LPTIMER, while the GD32L235xx has two 16 bit LPTIMER

(LPTIMER0, LPTIMER1).

## 5.10. Low-power universal asynchronous receiver/transmitter (LPUART)

The GD32L233xx has one LPUART, while the GD32L235xx has two LPUARTs (LPUART0, LPUART1).

## 5.11. VREF

The GD32L235xx can provides 2.5V/2.048V reference voltage, while GD32L233XX can only provides 2.5V reference voltage.

## 5.12. Segment LCD controller (SLCD)

1. For GD32L233 series, the SLCD module integrates an optional voltage output driver, which can enter the enhanced mode by enabling the VODEN bit of the SLCD\_CTL register. GD32L235 series does not support enhance mode.
2. GD32L235xx supports weak driving resistance selection, but GD32L233xx does not.
3. For GD32L233 series, when using the internal voltage, the VSLCD value can be selected from VSLCD0 to VSLCD7 by the CONR[2:0] bits in the SLCD\_CFG register (Refer to the product datasheet for the VSLCDx values). The application can adjust the contrast according to the change of VSLCD value. For GD32L235 series, when using the internal voltage, when using the internal voltage, the VDD voltage as internal voltage source.
4. VSLCD voltage source configuration, Internal voltage source:
  - For GD32L233 series, when the SLCD selects the internal voltage source, the VSRC should be configured 1' b0 and the PD6 pin needs to be configured in analog mode. A external capacitor should be connected to GND. Please refer to Datasheet for the capacitance value.
  - For GD32L235 series, when the SLCD selects the internal voltage source, the VDD voltage as internal voltage.

## 5.13. Controller area network (CAN)

The GD32L235xx series has added CAN peripheral, while the GD32L233xx series do not.

#### **5.14. Universal Serial Bus full-speed device interface (USBD)**

1. For GD32L233xx device, the frequency of the APB1 bus clock must be not less than 24MHz. For GD32L235xx device, the frequency of the APB1 bus clock must be not less than 12MHz.
2. For GD32L235xx device, the USBD and CAN share the dedicated 512-byte SRAM memory.

## 6. Revision history

**Table 6-1. Revision history**

Revision No.	Description	Date
1.0	Initial Release	Jan.10 2024
1.1	Revision: Add explanation for L235 series SRAM parity check	Jul.8 2024

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